

STARPOWER

SEMICONDUCTOR

IGBT

GD800HFA120V6S

1200V/800A 2 in one-package

General Description

STARPOWER IGBT Power Module provides ultra low conduction loss as well as short circuit ruggedness. They are designed for the applications such as Motor drives and High-power converters.

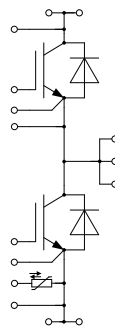
Features

- Low $V_{CE(sat)}$ Trench IGBT technology
- 10 μ s short circuit capability
- $V_{CE(sat)}$ with positive temperature coefficient
- Maximum junction temperature 175°C
- Low inductance case
- Fast & soft reverse recovery anti-parallel FWD
- Isolated copper baseplate using DBC technology

Typical Applications

- High-power converters
- Motor drives
- Traction drives

Equivalent Circuit Schematic



Absolute Maximum Ratings $T_C=25^{\circ}\text{C}$ unless otherwise noted**IGBT**

Symbol	Description	Value	Unit
V_{CES}	Collector-Emitter Voltage	1200	V
V_{GES}	Gate-Emitter Voltage	± 20	V
I_C	Collector Current @ $T_C=25^{\circ}\text{C}$ @ $T_C=95^{\circ}\text{C}$	1246	A
		800	
I_{CRM}	Repetitive Peak Collector Current $t_p=1\text{ms}$	1600	A
P_D	Maximum Power Dissipation @ $T_{vj}=175^{\circ}\text{C}$	3067	W

Diode

Symbol	Description	Value	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	1200	V
I_F	Diode Continuous Forward Current	800	A
I_{FRM}	Repetitive Peak Forward Current $t_p=1\text{ms}$	1600	A

Module

Symbol	Description	Value	Unit
T_{vjmax}	Maximum Junction Temperature	175	$^{\circ}\text{C}$
T_{vjop}	Operating Junction Temperature	-40 to +150	$^{\circ}\text{C}$
T_{STG}	Storage Temperature Range	-40 to +125	$^{\circ}\text{C}$
V_{ISO}	Isolation Voltage RMS, $f=50\text{Hz}$, $t=1\text{min}$	4000	V

IGBT Characteristics $T_c=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit	
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=800\text{A}, V_{GE}=15\text{V}, T_{vj}=25^\circ\text{C}$		1.30	1.75	V	
		$I_C=800\text{A}, V_{GE}=15\text{V}, T_{vj}=125^\circ\text{C}$		1.45			
		$I_C=800\text{A}, V_{GE}=15\text{V}, T_{vj}=150^\circ\text{C}$		1.50			
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=32.0\text{mA}, V_{CE}=V_{GE}, T_{vj}=25^\circ\text{C}$	5.5	6.1	7.0	V	
I_{CES}	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$			5.0	mA	
I_{GES}	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_{vj}=25^\circ\text{C}$			400	nA	
R_{Gint}	Internal Gate Resistance			0.38		Ω	
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, f=100\text{kHz}, V_{GE}=0\text{V}$		156		nF	
C_{res}	Reverse Transfer Capacitance			1.10		nF	
Q_G	Gate Charge	$V_{GE}=-8\dots+15\text{V}$		10.3		μC	
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=600\text{V}, I_C=800\text{A}, R_{Gon}=1.0\Omega, R_{Goff}=4.7\Omega, L_S=50\text{nH}, V_{GE}=-10/+15\text{V}, T_{vj}=25^\circ\text{C}$		631		ns	
t_r	Rise Time			191		ns	
$t_{d(off)}$	Turn-Off Delay Time			2391		ns	
t_f	Fall Time			167		ns	
E_{on}	Turn-On Switching Loss			126		mJ	
E_{off}	Turn-Off Switching Loss			148		mJ	
$t_{d(on)}$	Turn-On Delay Time		$V_{CC}=600\text{V}, I_C=800\text{A}, R_{Gon}=1.0\Omega, R_{Goff}=4.7\Omega, L_S=50\text{nH}, V_{GE}=-10/+15\text{V}, T_{vj}=125^\circ\text{C}$		915		ns
t_r	Rise Time				268		ns
$t_{d(off)}$	Turn-Off Delay Time				3014		ns
t_f	Fall Time				174		ns
E_{on}	Turn-On Switching Loss			244		mJ	
E_{off}	Turn-Off Switching Loss			175		mJ	
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=600\text{V}, I_C=800\text{A}, R_{Gon}=1.0\Omega, R_{Goff}=4.7\Omega, L_S=50\text{nH}, V_{GE}=-10/+15\text{V}, T_{vj}=150^\circ\text{C}$			979		ns
t_r	Rise Time				291		ns
$t_{d(off)}$	Turn-Off Delay Time				3158		ns
t_f	Fall Time				182		ns
E_{on}	Turn-On Switching Loss			275		mJ	
E_{off}	Turn-Off Switching Loss			181		mJ	
I_{SC}	SC Data		$t_p \leq 8\mu\text{s}, V_{GE}=15\text{V}, T_{vj}=150^\circ\text{C}, V_{CC}=800\text{V}, V_{CEM} \leq 1200\text{V}$		3200		A

Diode Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_F	Diode Forward Voltage	$I_F=800\text{A}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$		1.80	2.25	V
		$I_F=800\text{A}, V_{GE}=0\text{V}, T_{vj}=125^\circ\text{C}$		1.90		
		$I_F=800\text{A}, V_{GE}=0\text{V}, T_{vj}=150^\circ\text{C}$		1.95		
Q_r	Recovered Charge			63.8		μC
I_{RM}	Peak Reverse Recovery Current	$V_R=600\text{V}, I_F=800\text{A},$ $-di/dt=3580\text{A}/\mu\text{s}, L_s=50\text{nH},$ $V_{GE}=-10\text{V}, T_{vj}=25^\circ\text{C}$		338		A
E_{rec}	Reverse Recovery Energy			16.2		mJ
Q_r	Recovered Charge			128		μC
I_{RM}	Peak Reverse Recovery Current	$V_R=600\text{V}, I_F=800\text{A},$ $-di/dt=2390\text{A}/\mu\text{s}, L_s=50\text{nH},$ $V_{GE}=-10\text{V}, T_{vj}=125^\circ\text{C}$		336		A
E_{rec}	Reverse Recovery Energy			34.6		mJ
Q_r	Recovered Charge			148		μC
I_{RM}	Peak Reverse Recovery Current	$V_R=600\text{V}, I_F=800\text{A},$ $-di/dt=2180\text{A}/\mu\text{s}, L_s=50\text{nH},$ $V_{GE}=-10\text{V}, T_{vj}=150^\circ\text{C}$		336		A
E_{rec}	Reverse Recovery Energy			40.2		mJ

NTC Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
R_{25}	Rated Resistance			5.0		$\text{k}\Omega$
$\Delta R/R$	Deviation of R_{100}	$T_C=100^\circ\text{C}, R_{100}=493.3\Omega$	-5		5	%
P_{25}	Power Dissipation				20.0	mW
$B_{25/50}$	B-value	$R_2=R_{25}\exp[B_{25/50}(1/T_2-1/(298.15\text{K}))]$		3375		K
$B_{25/80}$	B-value	$R_2=R_{25}\exp[B_{25/80}(1/T_2-1/(298.15\text{K}))]$		3411		K
$B_{25/100}$	B-value	$R_2=R_{25}\exp[B_{25/100}(1/T_2-1/(298.15\text{K}))]$		3433		K

Module Characteristics $T_c=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
L_{CE}	Stray Inductance		10		nH
$R_{CC'+EE'}$	Module Lead Resistance, Terminal to Chip		0.35		m Ω
R_{thJC}	Junction-to-Case (per IGBT)			48.9	K/kW
	Junction-to-Case (per Diode)			67.3	
M	Terminal Connection Torque, Screw M3	0.9		1.1	N.m
	Terminal Connection Torque, Screw M8	8.0		10.0	
	Mounting Torque, Screw M6	3.0		6.0	
G	Weight of Module		1030		g

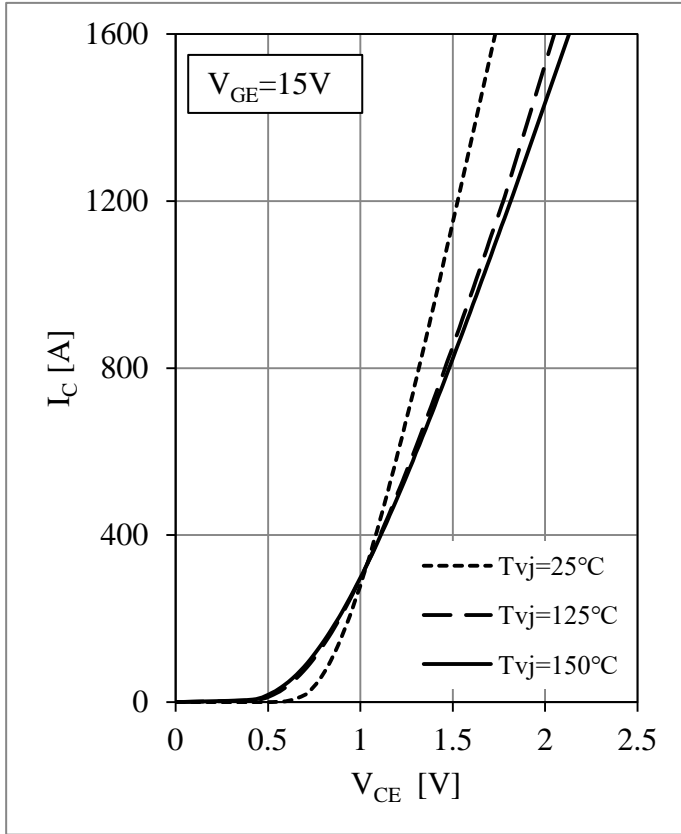


Fig 1. IGBT Output Characteristics

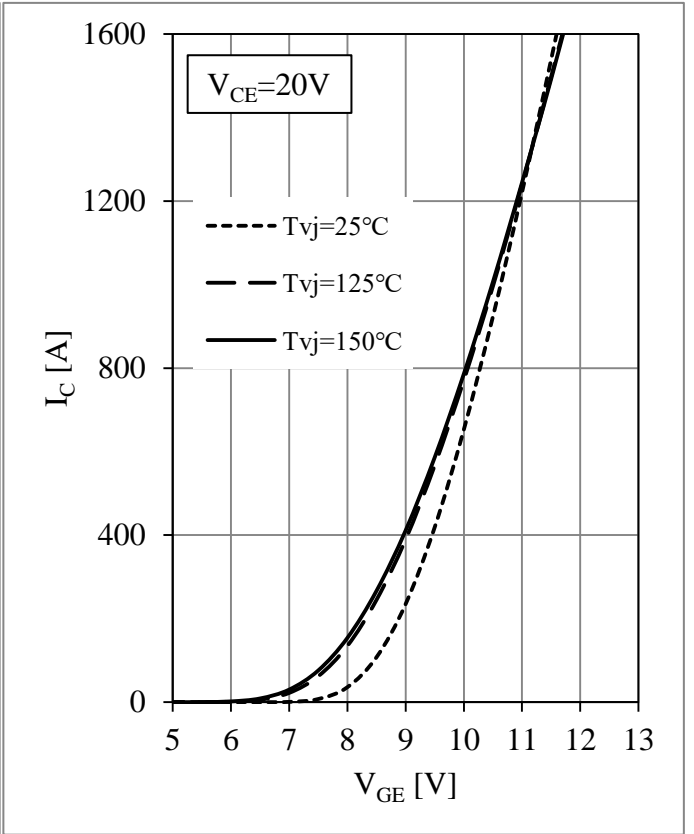


Fig 2. IGBT Transfer Characteristics

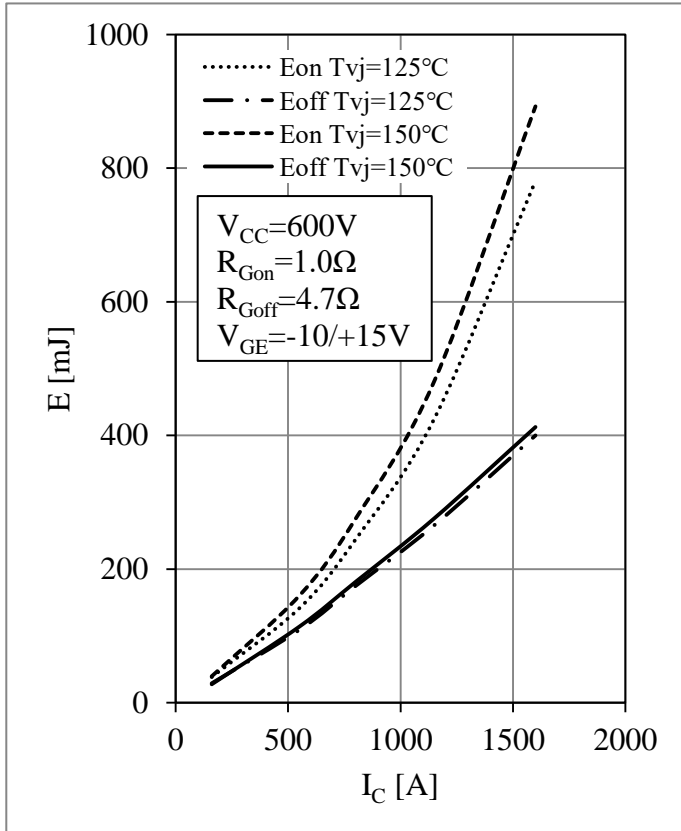


Fig 3. IGBT Switching Loss vs. I_c

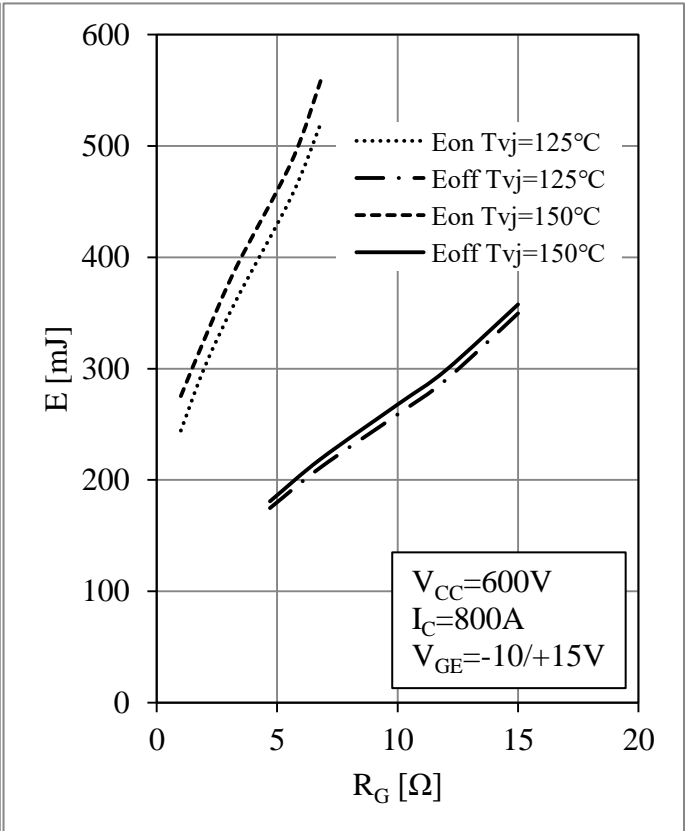


Fig 4. IGBT Switching Loss vs. R_G

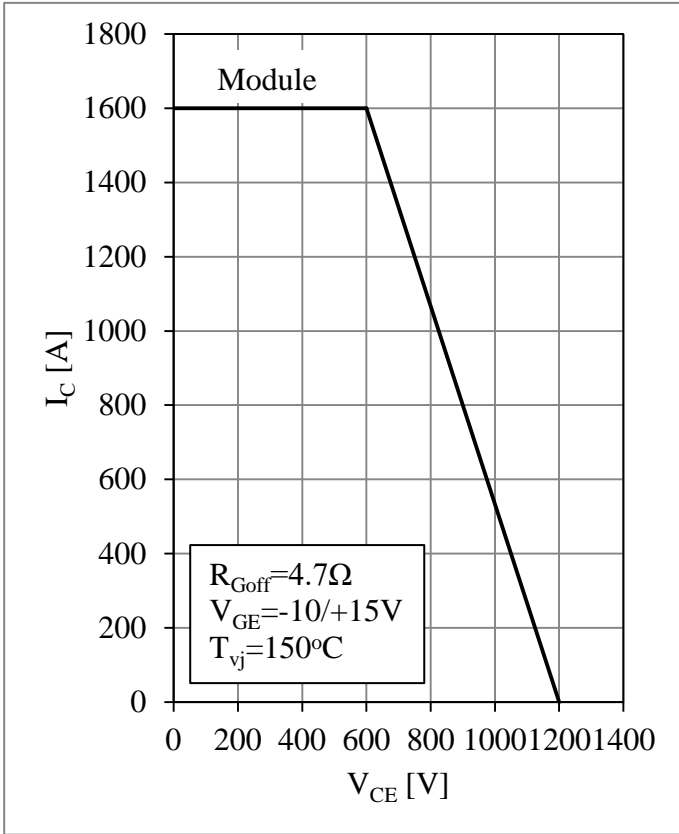


Fig 5. RBSOA

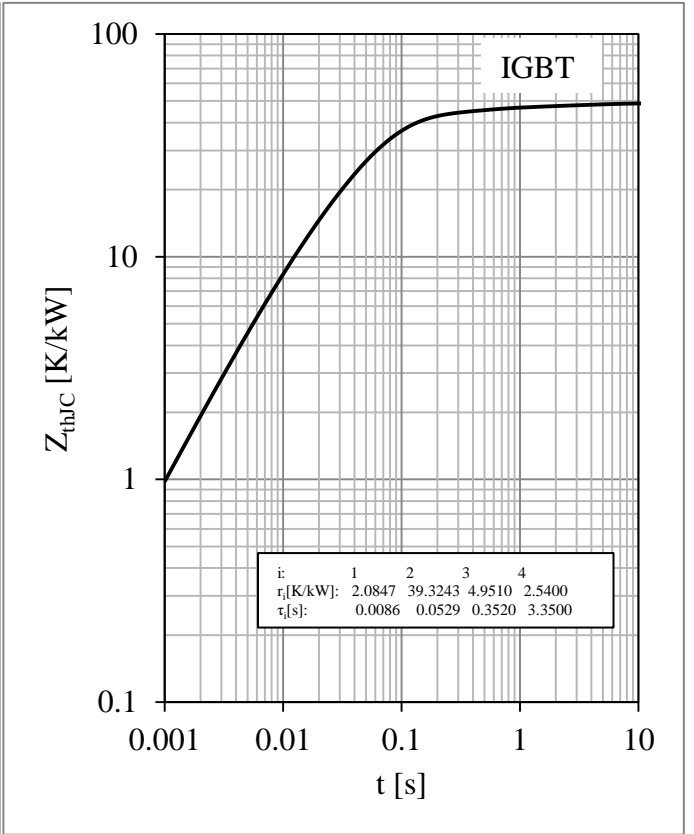


Fig 6. IGBT Transient Thermal Impedance

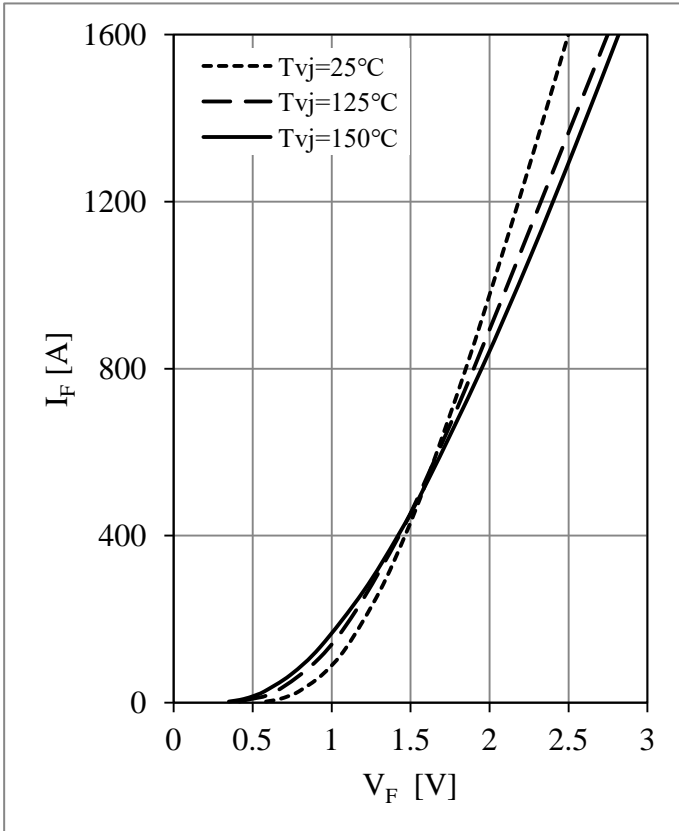


Fig 7. Diode Forward Characteristics

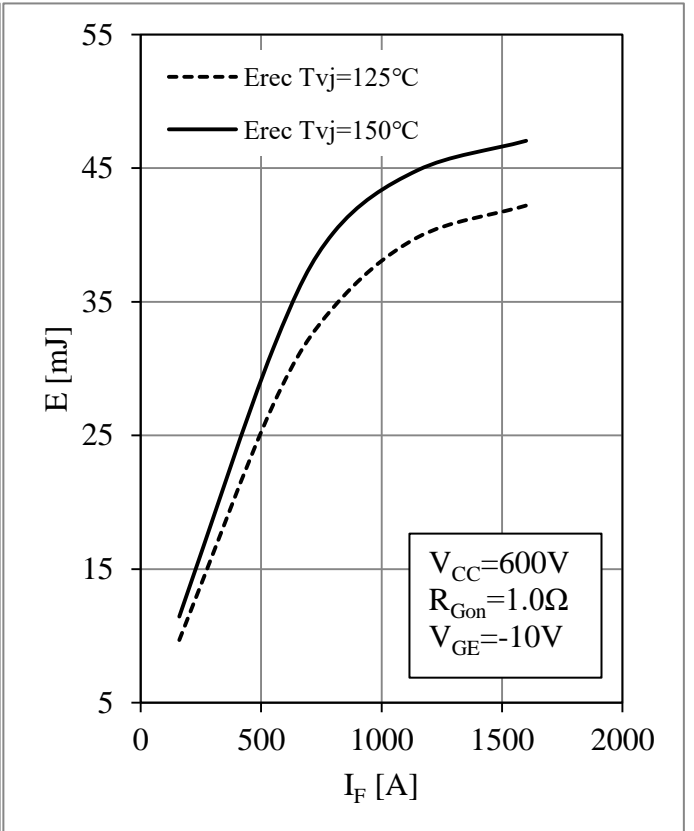


Fig 8. Diode Switching Loss vs. I_F

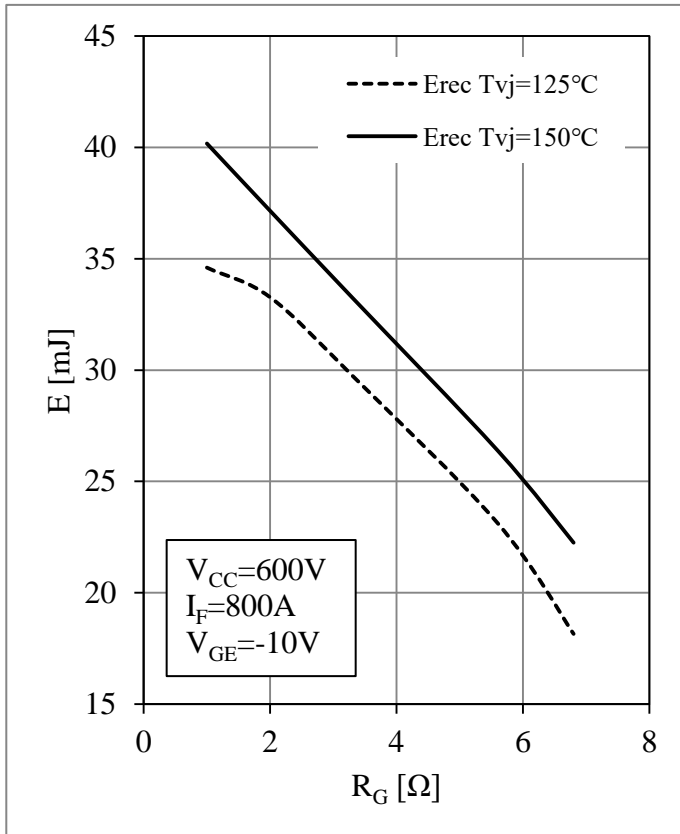


Fig 9. Diode Switching Loss vs. R_G

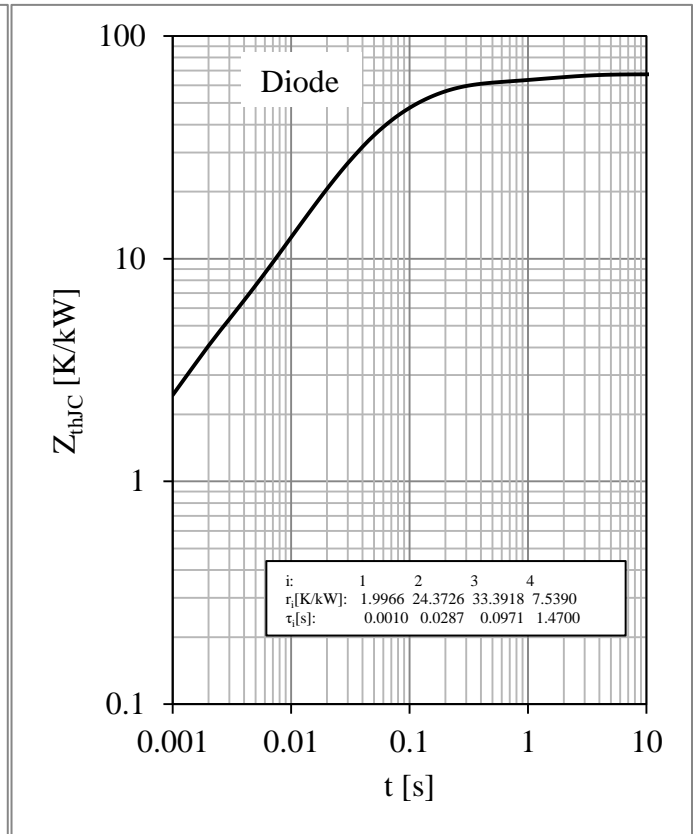
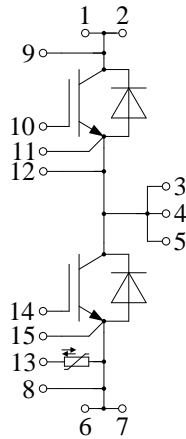


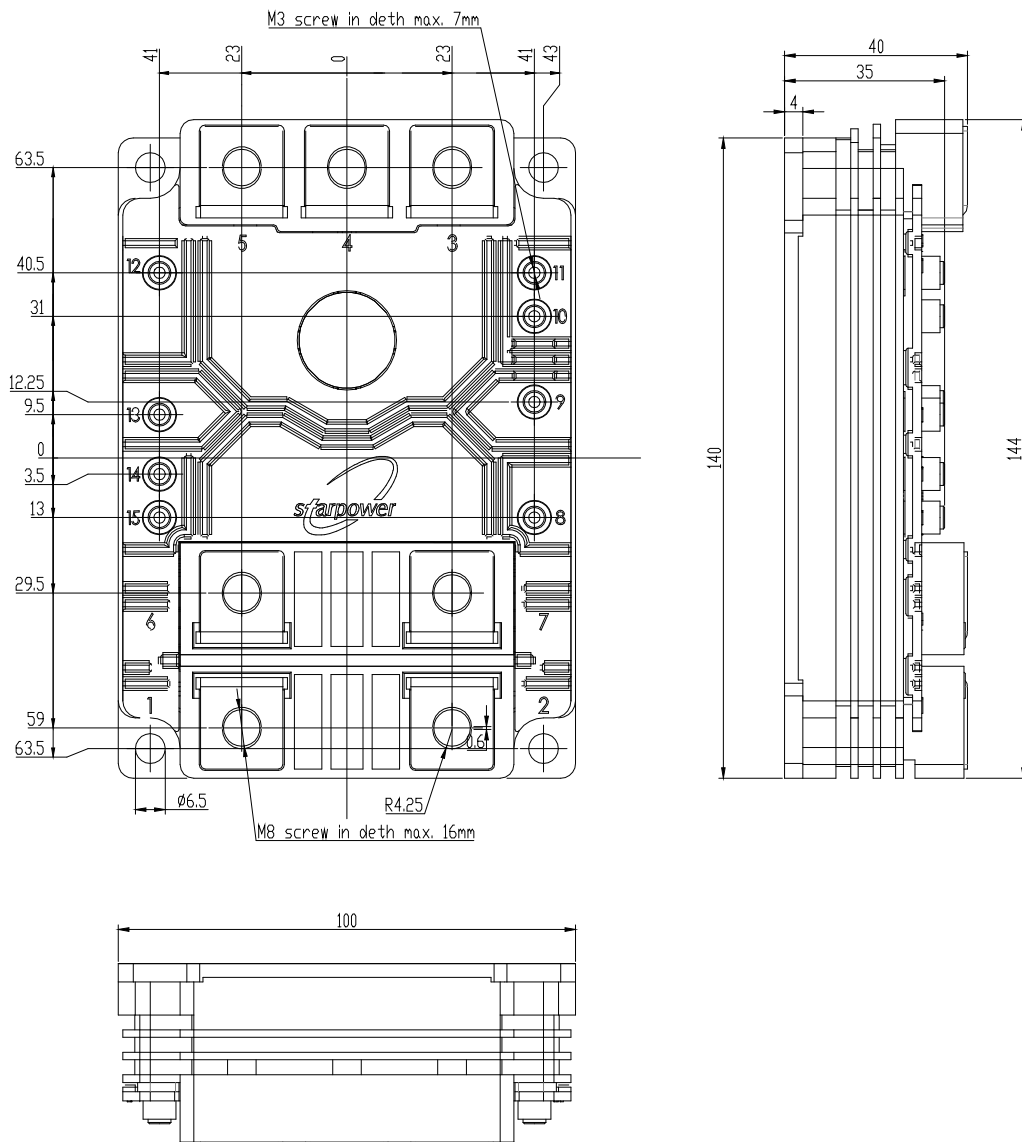
Fig 10. Diode Transient Thermal Impedance

Circuit Schematic



Package Dimensions

Dimensions in Millimeters



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